	Application/Control No.	Applicant(s)/Patent Under Reexamination
Issue Classification	09736168	MATSUMOTO, NAOTO
	Examiner	Art Unit
	Rampuria, Satish S	2191

CLASS SUBCLASS CLAMED ORIGINAL  CLASS SUBCLASS PER BLOCK)  CLASS SUBCLASS PER BLOCK)  CLASS SUBCLASS PER BLOCK)  7.77  CLASS SUBCLASS PER BLOCK)  7.77			Rampuria, Satish S		2191					
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CROSS REFERENCE(S)  1.455  1.174  1.175  1.177  1.175  1.177  1.175  1.177  1.177  1.175  1.177  1.1	CLASS		SUBCLASS	CLAIME				NON	CLAIMED	
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